



## LOT2200E Series Mini-OTDR



## Feature

- ✤ 4.3-inch full-view capacitive multi-touch screen
- Standard USB interface supports a variety of external devices, such as U disk, mouse, etc.
- Uploading testing results to computer via Type-C interface
- Internal storage of 1000 groups + SD memory up to 10K groups of testing result
- Li-ion rechargeable battery, support charge pal charging

6. Event Map

## Eight-in-one

- 1. OTDR 5. RJ45 Cable test
- 2. OPM
- 3. VFL 7. Loss test
- 4. LS 8. Flashlight





## **Specifications:**

Model	LOT2200-SD26	LOT2200-MD26	LOT2200-SS26	
Wavelength	1310/1550 nm	850/1300 nm	1310 or 1550nm	1610 or 1625 or 1650 nm
Dynamic Range (1)	24/22 dB	22/26 dB	(with filter) 26 dB	(with filter) 24 dB
EDZ <sup>(2)</sup>	24/22 0D	3m	20 0D	24 00 2m
ADZ <sup>(2)</sup>	8m	10m	8m	8m
Measuring Range	100m、500m、2km、5km、10km、20km、40km、80km、100km			
Pulse Width	SM: 5ns, 10ns, 20ns, 50ns, 100ns, 200ns, 500ns, 1µs, 2µs, 5µs, 10µs MM: 5ns, 10ns, 20ns, 50ns, 100ns, 200ns, 500ns, 1µs, 2µs			
Samplingresolution	Minimum: 0.25m			
The sampling point	20,000 points			
Linearity	≤0.05dB/dB			
Loss threshold	0.01dB			
Loss resolution	0.001dB			
Range resolution	0.01m			
Range accuracy	$\pm$ (0.5m+Range×3×10 <sup>-5</sup> +Sampling resolution) (Excluding refractive index error)			
Memory	Internal storage of 1000 groups of data + SD memory card (optional)			
OPM	Type A : +10dBm~-70dBm;Type B : +26dBm~-50dBm			
OLS	The output power: -5dBm; Modulation frequency: CW / 270Hz / 1KHz / 2KHz			
VFL	10mW , CW / 2Hz			
Network Cable test	Support network wire sequence testing and wire alignment			
Data interface	2×USB(Type A ×1, Type C ×1), SD card slot			
Screen	4.3-inch TFT-LCD, Multi-Touch			
Battery	3.7V/5200mAh			
Temperature	Workingtemperature : -10℃~+55℃;Storagetemperature : -20℃~+80℃			
Humidity	≤95% (No condensation)			
Size/Weight	175x105x45mm / 0.5 kg (battery included)			
Standard Accessories	Power Adapter, Rechargeable Lithium Battery, FC Adaptor, USB Cable, User's Guide, Carrying Bag			

Note: (1) Dynamic range is measured with maximum pulse width, averaging time is 3 minutes, SNR=1; The level difference between the RMS noise level and the level where near end back-scattering occurs.
(2) Event dead zone and attenuation dead zone are measured with pulse width of 5ns;